

CMOS 14-STAGE RIPPLE-Carry Binary Counter/Dividerand Oscillator

High-Voltage Types (20-Volt Rating)

■ XD4060 consists of an oscillator section and 14 ripple carry binary counter stages. The oscillator configuration allows design of either RC or crystal oscillator circuits. A RESET input is provided which resets the counter to the all-0's state and disables the oscillator. A high level on the RESET line accomplishes the reset function. All counter stages are master -slave flip-flops.

The state of the counter is advanced one step in binary order on the negative transition of ϕ_1 (and ϕ_0). All inputs and outputs are fully buffered. Schmitt trigger action on the input-pulse line permits unlimited input-pulse rise and fall times.

Applications

- Control counters
- Timers
- Frequency dividers
- Time-delay circuits

Features:

- 12 MHz clock rate at 15 V
- Common reset
- Fully static operation
- Buffered inputs and outputs
- Schmitt trigger input-pulse line
- 100% tested for quiescent current at 20 V
- Standardized, symmetrical output characteristics
- 5-V, 10-V, and 15-V parametric ratings

Oscillator Features:

- All active components on chip
- RC or crystal oscillator configuration
- RC oscillator frequency of 690 kHz
- min. at 15 V

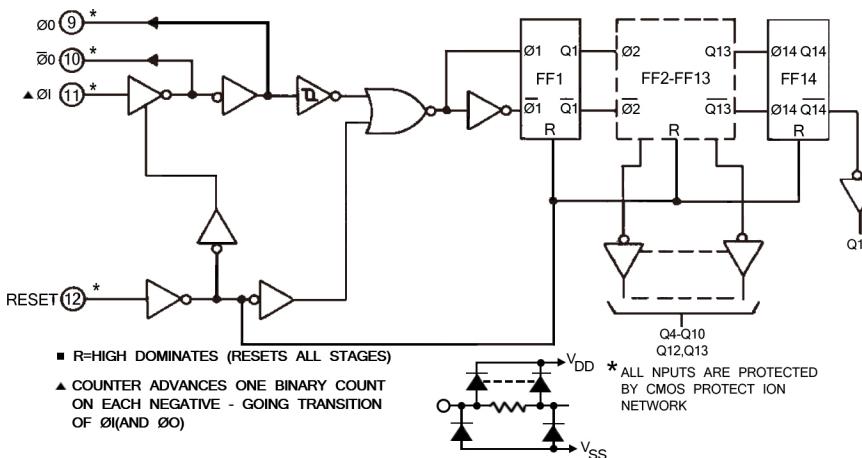
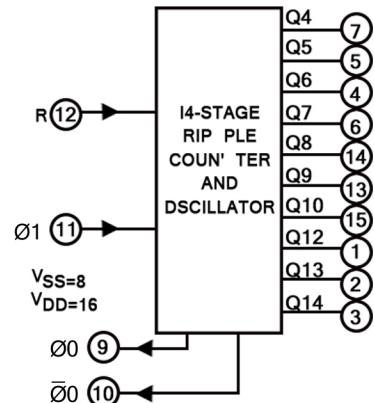


Fig.1 - Logic diagram.

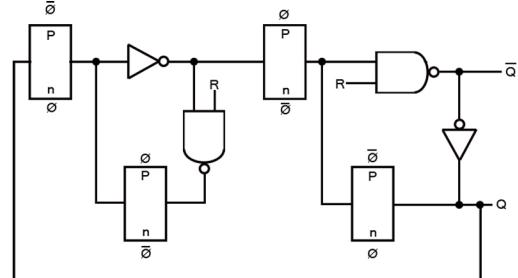


Fig.2 - Detail of typical flip-flop stage.

MAXIMUM RATINGS,Abaolute-Maximum Values: DC SUPPLY-VOLTAGE RANGE, (VDD)

Voltage referenced to VSS Terminal -0.5V to + 20V

INPUT VOLTAGE RANGE, ALL INPUTS -0.5V to VDD + 0.5V

DC INPUT CURRENT, ANY ONE INPUT ±10mA

POWER DISSIPATION PER PACKAGE (PD):

For TA = -55°C to +100°C 500mW

For TA = +100°C to +125°C Derate Linearity at 12mW/°C to 200mW

DEVICE DISSIPATION PER OUTPUT TRANSISTOR

FOR TA = FULL PACKAGE-TEMPERATURE RANGE (All Package Types) 100mW

OPERATING-TEMPERATURE RANGE -55°C to +125°C

STORAGE TEMPERATURE RANGE -65°C to +150°C

LEAD TEMPERATURE (DURING SOLDERING):

At distance 1/16±1/32 inch (1.59±0.79mm) from case for 10s max +265°C

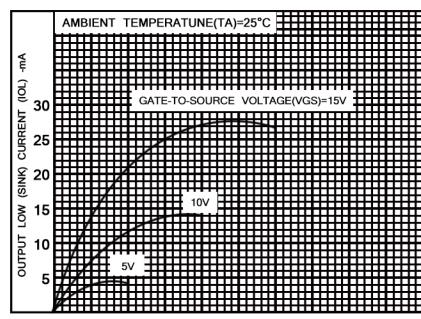


Fig.3 - Typical n-channel output low (sink) current characteristics.

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STATIC ELECTRICAL CHARACTERISTICS

CHARAC- TERISTIC Quiescent	CONDITIONS			LIMITS AT INDICATED TEMPERATURES(°C)						U N T S
	V_O (V)	V_{IN} (V)	V_{DD} (V)					+25		
Device Current, I_{DD} Max.	-	0,5	5	5	5	150	150	-	0,04	5
	-	0,5	10	10	10	300	300	-	0,04	10
	-	0,15	15	20	20	600	600	-	0,04	20
	-	0,20	20	100	100	3000	3000	-	0,08	100
Output Low (Sink) Current*, I_{OL} Min.	0,4	0,5	5	0,64	0,61	0,42	0,36	0,51	1	-
	0,5	0,10	10	1,6	1,5	1,1	0,9	1,3	2,6	-
	1,5	0,15	15	4,2	4	2,8	2,4	3,4	6,8	-
Output High (Source) Current*, I_{OH} Min.	4,6	0,5	5	-0,64	-0,61	-0,42	-0,36	-0,51	-1	-
	2,5	0,5	5	-2	-1,8	-1,3	-1,15	-1,6	-3,2	-
	9,5	0,10	10	-1,6	-1,5	-1,1	-0,9	-1,3	-2,6	-
	13,5	0,15	15	-4,2	-4	-2,8	-2,4	-3,4	-6,8	-
Output Voltage: Low-Level, V_{OL} Max.	-	0,5	5					-	0	0,05
	-	0,10	10					-	0	0,05
	-	0,15	15					-	0	0,05
Output Voltage: High-Level, V_{OL} Min.	-	0,5	5				4,95	5	-	-
	-	0,10	10				9,95	10	-	-
	-	0,15	15				14,95	15	-	-
Input Low Voltage V_{IL} Max.	0,5,4,5	-	5				-	-	1,5	
	1,9	-	10				-	-	3	
	1,5,13,5	-	15				-	-	4	
Input High Voltage V_{IH} Min.	0,5,4,5	-	5				3,5	-	-	
	1,9	-	10				7	-	-	
	1,5,13,5	-	15				11	-	-	
Input Current I_{IN} Max.	-	0,18	0,18	$\pm 0,1$	$\pm 0,1$	± 1	± 1	-	$\pm 10^{-5}$	$\pm 0,1$
										μA

*Data not applicable to terminal 9 or 10.

RECOMMENDED OPERATING CONDITIONS

For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges

CHARACTERISTIC	V_{DD}	LIMITS		UNITS
		MIN	MAX	
Supply-Voltage Range(For TA = Full Range Temperature)	-	3	18	V
Input-pulse Width, t_W ($f=100\text{kHz}$)	5 10 15	100 40 30	-	ns
Input-Pulse Rise Time and Fall Time, t_{r0}, t_{f0}	5 10 15	Unlimited		
Input-Pulse Frequency, f_{01} (External pulse source)	5 10 15	-	3,5 8 12	MHz
REster pulse width, t_W	5 10 15	120 60 40	-	ns

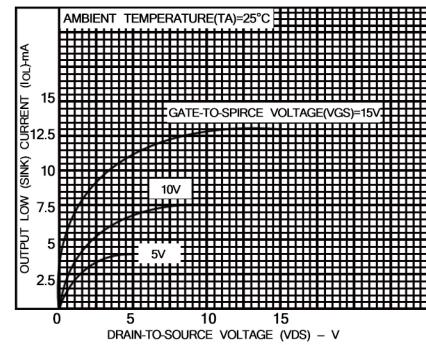


Fig.4 - Minimum n-channel output low (sink) current characteristics.

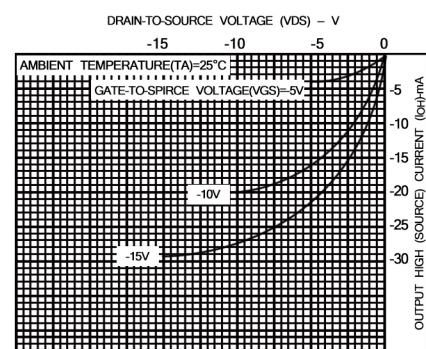


Fig.5 - Typical p-channel output high (source) current characteristics.

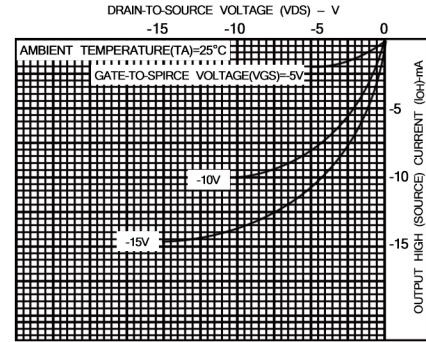


Fig.6 - Minimum p-channel output high (source) current characteristics.

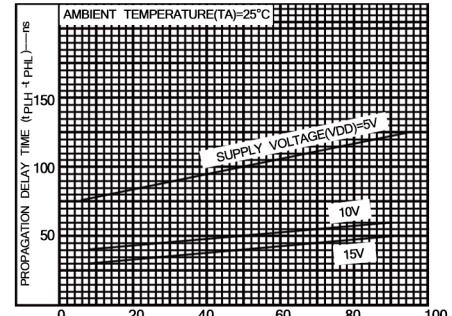


Fig.7 - Typical gate-to-source propagation delay time (Qn to Qn+1) as a function of load capacitance.

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DYNAMIC ELECTRICAL CHARACTERISTICS at TA = 25°C, Input tr,tf = 20ns,
 $C_L = 50 \text{ pF}$, $R_L = 200 \text{ k}\Omega$

CHARACTERISTIC	TEST CONDITIONS	V_{DD} (V)	LIMITS			UNITS	
			MIN	TYP	MAX		
Input-Pulse Operation							
Propagation Delay Time, $t_{Q1} \text{ to } Q4$ Out; t_{PHL}, t_{PLH}		5	—	370	740	ns	
		10	—	150	300		
		15	—	100	200		
Propagation Delay Time, Q_n to $Q_n + 1$; t_{PHL}, t_{PLH}		5	—	100	200		
		10	—	50	100		
		15	—	40	80		
Transition time, t_{THL}, t_{TLH}		5	—	100	200		
		10	—	50	100		
		15	—	40	80		
Min. Input-Pulse Width, t_W	f = 100kHz	5	—	50	100		
		10	—	20	40		
		15	—	15	30		
Input-Pulse Rise & Fall Time, $t_{r\phi}, t_{f\phi}$		5	Unlimited				
		10	Unlimited				
		15	Unlimited				
Max. Input-Pulse Frequency, f_{Q1} (External pulse source)		5	3.5	7	—	MHz	
		10	8	16	—		
		15	12	24	—		
Input Capacitance, C_1	Any Input	—	8	7.5	pF		
Reset Operation							
Propagation Delay Time, t_{PHL}		5	—	180	360	ns	
		10	—	80	160		
		15	—	50	100		
Minimum Reset Pulse Width, t_W		5	—	60	120		
		10	—	30	60		
		15	—	20	40		

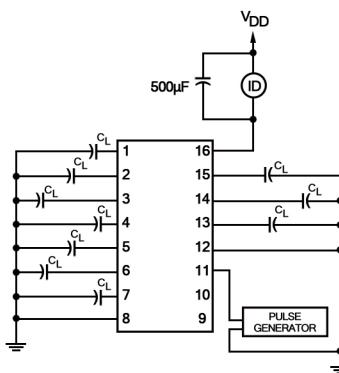


Fig.11-Dynamic power dissipation test circuit.

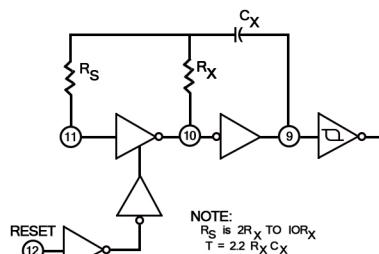


Fig.12-Typical RC circuit.

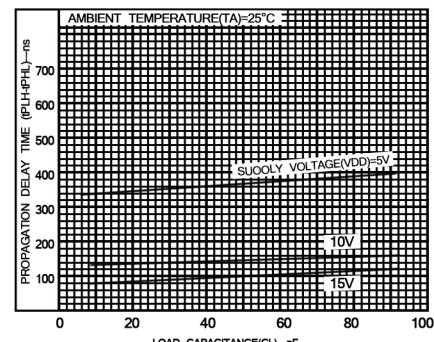


Fig.8-Typical propagation delay time (t_{Q1} to $Q4$ Output) as a function of load capacitance.

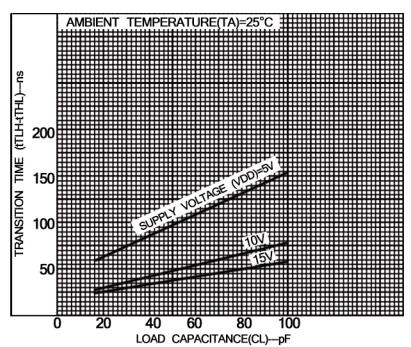


Fig.9-Typical transition time as a function of load capacitance.

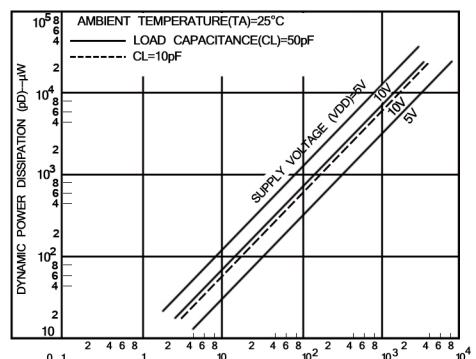


Fig.10-Typical dynamic power dissipation as a function of input frequency.

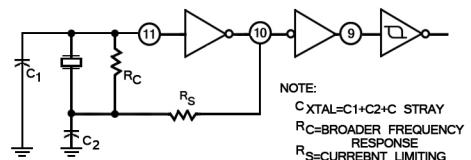


Fig.13-Typical crystal circuit.

DYNAMIC ELECTRICAL CHARACTERISTICS at TA = 25°C, Input tf,tf = 20 ns,
CL = 50pF, RL=200kΩ [cont'd]

CHARACTERISTIC	TEST CONDITIONS	V _{DD} (V)	LIMITS			UNITS
			Min	Typ	Max	
RC Operation						
Variation of Frequency(Unit-to-Unit)	C _X =200pF, R _S =560kΩ, R _X =50kΩ	5	-	23±10%	-	kHz
		10	-	24±10%	-	
		15	-	25±10%	-	
Variation of Frequency with voltage change(Same Unit)	C _X =200pF, R _S =560kΩ, R _X =50kΩ	5V to 10V 10V to 15V	-	1.5 0.5	-	
R _X max.	C _X =10μF, =50μF, =10μF	5	-	-	20	MΩ
		10	-	-	20	
		15	-	-	10	
C _X max.	R _X =500kΩ =300kΩ =300kΩ	5	-	-	1000	μF
		10	-	-	50	
		15	-	-	50	
Maximum Oscillator Frequency*	R _X =5kΩ R _S =30kΩ C _X =15pF	10	530	650	810	kHz
		15	690	800	940	
Drive Current at Pin 9(For Oscillator Design)	I _{OL}	V _O =0.4V	5	0.16	0.35	mA
		=0.5V	10	0.42	0.8	
		=1.5V	15	1	2	
	I _{OH}	V _O =4.6V	5	-0.16	-0.35	
		=9.5V	10	-0.42	-0.8	
		=13.5V	15	-1	-2	

*RC oscillator applications are not recommended at supply voltages below 7V for RX <50 kΩ.

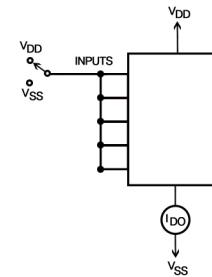


Fig.14-Quiescent device current.

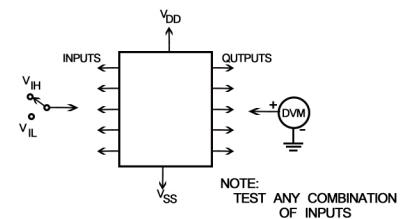


Fig.15-Input voltage.

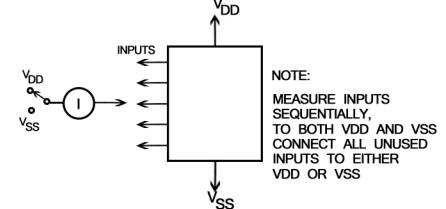
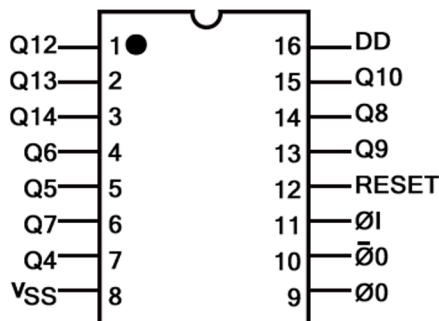
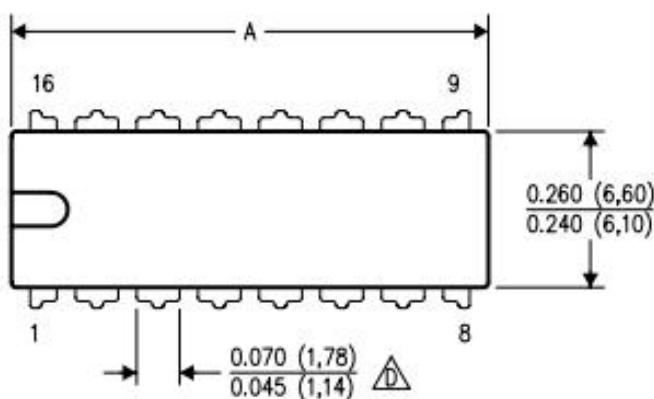


Fig.16-Input current

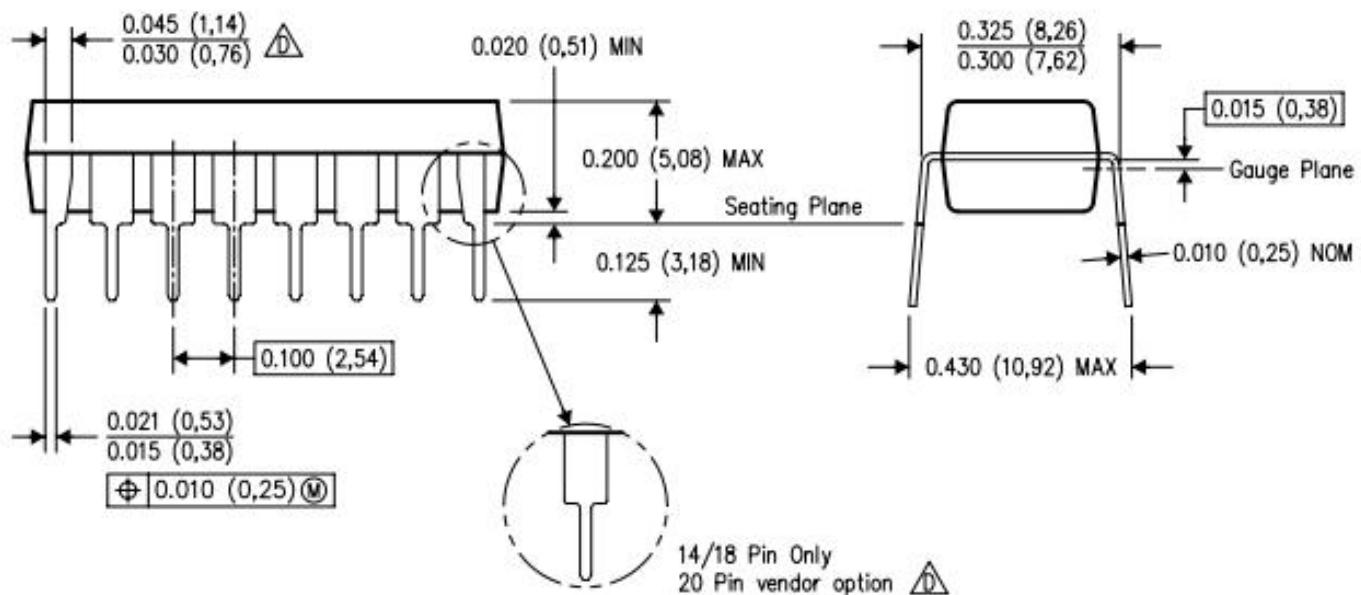
TERMINAL DIAGRAM



DIP



PINS **\nDIM	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS-001 VARIATION	AA	BB	AC	AD



以上信息仅供参考. 如需帮助联系客服人员。谢谢 XINLUDA